CRITICAL ITEMS LIST

ASSY. NOMENCLATURE <u>CCTV/ITVC</u>

ASSY. P/N 2000744261

FAILURE EFFECT								
NAME, QTY & DRAWINGS REF, DESIGNATION		FAILURE MODE	END			CREWA	DATESTALE FOR ACCEPTANCE	CATE
REF, DESIGNATION	FUNCTION	AND CAUSE	ITED	INTERFACE	NISSION	VEHICLE	RATIONALE FOR ACCEPTANCE	OATE
	2/2	A malfunction in the Camera	Loss of Camera Output Morst Case Loss of	No Video	Loss of Hissian Critical Video		See Sheet ?	:
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DESIGN FEATURES

The ITVC is comprised of 20 electrical subassemblies: 13 subassemblies are Lockheed Hartin Astro Space designed and fabricated using standard printed circuit board type construction. The remaining six assemblies, 3 stepper motors, Nigh Yoltage Pomer Supply (HVPS), Intensified CCD (ICCD), and Lens assembly are vendor supplied compoments, which have been specified and purchased according to Lockheed Harlin Specification Control Drawings (SCDs) prepared by Engineering and Product Assurance. Specifications per the SCO are performance, test. qualification, and acceptance requirements for a procured piece of equipment. Parts, materials, processes, and design quidelines for the ITVC program are specified in accordance with Lockheed Martin 3267828. This document defines the program requirements.

NIL-SID-9/56 will serve as the primary ELE parts selection document. If a suitable part cannot be found in MIL-SID-975G, equivalent EEE parts that meet the following criteria may be substituted.

Microcircuits are at least Class O Level, MIL-M-38510 devices. All microcircuits are subjected to Particle Impact Moise Detection (PEMO) testing per MIL-STD-683C (except for devices with plastic epoxytype package).

Diodes and transistors are at least JANIXV in accordance with MIL-S-19500. All semiconductors in cavity-type packages are subjected to PINO testing per MIL-S10-8030.

DESIGN FCATURES (Cont.)

Relays are produced to the highest military established reliability (MIL-FR) tevel as defined in MIL-R-390)6. Relays are subject to PINU testing.

Switches are procured to at least the second highest level of the appropriate MIL-ER specification. Switches are subjected to either PIMO testing or X-ray analysis as appropriate, for particle detection.

Other discrete parts are procured to at least the second highest level of the appropriate MIL-ER specification.

Parts not included in the above documents have been used in the design only alter a non-standard parts acceptance request (MSPAR) has been prepared, submitted to Reliability Assurance Engineering and approved for use in the specific application(s) defined in the NSPAR by NASA-JSC.

Worst case circuit analyses have been performed and documented for all circuit designs to demonstrate that sufficient aperating margins exist for all operating conditions. The analysis was worst case in that the value for each of the variable parameters was set to limits that will drive the output to a maximum (or min.) A component approach review and analysis was conducted to verify that the applied stress on each piece part by the temperature extremes identified with environmental qualification testing does not exceed the stress derating values identified in Lockheed Martin 3267828.

DESIGN FLATURES (Cont.)

In addition, an objective examination of the design was performed through a Preliminary Design Review and Critical Ocsign Review to verify that the ITVC met specification and contractual requirements.

DAME BOARD DESIGN All boards are constructed from laminated copper-clad epoly glass sheets per-MIL-P-13949 Type OF Grade A. Circuit connections are made through printed traces which run from point to point on the board surfaces. Every trace terminates at an annular ring. The annular ring surrounds the hole in which a component lead or terminal is located. This ring provides a facting for the solder, ensuring good medianical and electrical performance. Its size and shape are governed by NIL-P-S5640. as are trace widths, spacing and routing. These requirements are reiterated specifically in drawing notes to further assure compliance. Variations between the artwork master and the final product (due to irregularities of the etching process) are also controlled by drawing notes. This prevents making defective boards from good artwork. Hules which house no lead or terminal, but serve only to electrically interconnect the different board layers. contain stitch hars for mechanical support

The through holes are drilled from a drill tape thus eliminating the possibility of human error and allowing tight control over hole and annular ring concentricity, an important reliability criterion. After drilling and etching, all copper cladding

and increased rellability.

RATIONALE FOR ACCIPIANCE. (Continued)

BARE BUARD DESIGN (Cont.)
is tim-lead plated per MIL-SID-1495. This
provides for easy and reliable soldering
at the time of board assembly, even after
periods of prolonged storage.

BOARD ASSEMBLY DESIGN

Ail components are installed in a manner which assures maximum reliability. Component leads are pre-limned, allowing total wetting of solder joints. All leads are formed to provide stress relief and the bodies of large components are staked. Special mounting and handling instructions are included in each drawing required after final assembly. The board is coated with wrethane which protects against humidity and contamination.

ACCEPTANCE TEST

Fach assembly is individually tested to a MASA approved Acceptance Test Procedure IP-AI-20007442. The Acceptance Test Flow is detailed in altached Table I.

QUALIFICATION_TIST

The Qualification unit is identical to the flight unit configuration in every respect and is used solely for the purpose of qualification testing. The Qual unit must successfully complete acceptance testing prior to entering qualification testing. The Qual unit has passed testing in accordance with NASA approved test plan PN-C-ZUUU7442. The Qualification fest flow is detailed in attached fable 2.

OPERATIONAL TESTS

In order to verify that CCTV components are operational, a test must verify the health of all the command related components from the PHS (A/AI) panel switch, through the RCU, through the sync lines to the Camera/PHU, to the Camera/FHU command decoder. The test must also verify the camera's ability to produce video, the YSU's ability to route video, and the monitor's ability to display video. A similar test would be performed to verify the NOM command path.

Pro-Launch on Drbiter Test/In-Flight Test

- 1. Power CCTV System.
- Via the PNS panel, select a monitur as destination and the camera under test as source.
- Send "Camera Power On" command from the PHS panel.
- Select "External Sync" on monitor.
- Observe video displayed un munitur. Note that if video on monitor is synchronized fi.e., stable raster) then this indirates that the camera is receiving composite sync from the RCU and that the camera is producing synchronized video.
- Send Pan, Tilt, Focus, Zoom, ALC, and Gamma commands and visually (either via the monitor or direct observation) verify operation.
- Select downlink as destination and camera under test as source.
- 8. Observe video couted to downlink,
- Send "Camera Power Olf" command via PNS panel.
- Repeat Steps 3 through 9 except issue commands via the NDH command path.

NOTIONS

Procurement Control - The TIVE EEE Parts and hardware items are procured from approved wendors and suppliers, which meet the requirements set forth in the TIVE contract. Resident DPRO personnel review all procurement documents to establish the need for GSL on selected parts [PAI 517].

Incoming Inspection and Storage - Incoming Quality inspections are made on all received materials and parts. Results are recorded by lot and retained in file by drawing and control numbers for future reference and traceability. All EEE parts are subjected to incoming acceptance tests as called for in PAP A4.14 - Incoming Insuretion Test Instructions. Incoming flight parts are further processed in accordance with Lockheed Martin 3267B2B. Mechanical items are inspected per PAP A4.14 - Supplier Quality Assurance, and PAP E10.8.1 - Procedure for Processing Incoming or Purchased Parts Designated for Flight Usa. Accepted lers are delivered to Material Controller. Stores and retained under specified conditions until fabrication is required. Non-conforming materials are held for Material Review Doard (MRB) disposition. (PAP A4.14.)

<u>Noard Assembly & Test</u> - Prior to the start of TVC board assembly, all items are verified to be correct by stock room personnel, as the Items are accumulated to form a kit. The Items are verified again by the operator who assembles the kit by checking against the as-built-parts-list (AUPL). OPRO Mandatory Inspection Points are designed for all

QAZINSPECTION (Cont.)

printed circuit. plus harness connectors for suldering wiring, crimping, solder splices and quality workmanship prior to coating of the component side of boards and sleeving of harnesses.

QAZINSPECTION (Cont.)

ITVC Boards

Specific ITVC board assembly and test instructions are provided in drawing notes. and applicable documents are called out in the Fabrication Procedure and Record (1PR-2000/442) and parts list P120007442. These include Process Standard-Honding RTV-566 2200081, Process Standard - Bonding Veloro Tape 2200089, Specification Soldering 2200749, Specification - Crimp-Ing 2200000, Specification - Bonding and Staking 2200078, Specification - Urethane coating 2200077, Specification - Marking Z280876, Specification - Workmanship 8030035, Specification Sonding and Staking 2280875. Specification-Wave Solder 2280821, Specification-Printed Wire Board Staking ZZBOB51, Specification-Reflow Soldering 2200754, Specification-Soldering Surface Mount Commonents 20005710.

QA/CNSPECTION (Cont.)

ITVC Assembly and Test

An open box test is performed per [P-II-20007442 and an Acceptance Test per IP-AI-20007442, including vibration and thermal vacuum. Turques are specified and witnessed, traceability numbers are recorded and calibrated tools are checked prior to use. tookheed Martin Quality and DPRO inspections are performed at the completion of specified FPR operations in accordance with PAP-2.6.1, PAP-2.9, PAP-2.11, PAP-E6.1, and PAP-8.5. OPRO personnel witness ITVC button-up and critical torquing.

The ITVC is packaged according to NASA documents NABB6000. IC and NABB300.4(ID2) which defines packaging and handling requirements. All related documentation including assembly drawings, Parts List, ABPL, Test Data, etc., is gathered and held in a documentation folder assigned specifically to each assembly. This folder is retained for reference. An EIDP is prepared for each assembly to accordance with the requirements of PAP E2.3. Lockheed Hartin QC and DPRO personorl witness trating, packaging, packing, and marking, and review the EIDP for completeness and accuracy.

TABLE 1. ACCEPTANCE TEST FLOW

3. ROOM AHBIENT, PLREORMANCE FEST

Test conducted per the requirements of MASA approved TP-AT-20007442.

2. ACCEPTANCE VIBRATION, EXPOSURE

20-80 Hz: 3 dB/ogtave rise from 0.01 g²/Hz to 0.04 g²/Hz to 80-350 Hz: 0.04 g²/Hz

350-2000 Hz: 3 d \tilde{M} /octave decrease to 0.006 q^2/Hz Test Duration:) minute/axis, operating

Test Level: 6.1 gras

3. POST-VIBRATION FUNCTIONAL CHECK

lest conducted per the requirements of NASA approved TP-AT-20007442.

4. ACCEPTANCE THERMAL-VACUUM, EXPOSURE

1.5 cycles total from +115 deg F to +14 deg F. After stabilization, one hour minimum duration at each plateau. In-spec functional tests performed at each plateau.

5. <u>POST-ENVIRONMENTAL PERFORMANCE TEST</u>

Room ambient performance lests conducted in accordance with NASA approved TP-AT-20007442.

TABLE 2. QUALIFICATION TEST FLOW

FMI

Conducted tests run in accordance with the requirements of SL-E-OBO28, including CSO1. CSO2, CSO6, TTO1, CEO!; and CEO3. Radiated tests run in accordance with SL-E-00020 including MSO2, MSO3, and REO2 except that the test current for RSO2 was 2 amps in lieu of 20 amps.

2. QUAL TOR ACCEPTANCE VIBRATION

20-80 Hz: 3 dB/uctave increasing to 0.067 o^2/Hz

80-350 Hz: 0.067/actave

350-2000 Hz: 3 dB/octave decrease

Test Level: 7.8 gras

Test Duration: 5 minutes/axis operating

3. <u>LLIGHE QUALIFICATION VIBRAJION</u>

20~70 Hz: θ dB/ogtave increasing to 0.4 g²/Hz

70-500 Hz: 0.4 g²/Hz

lest Level: 18.1 grms

Test Duration: 40 minutes/axis non-operating

4. THERMAL-YACUUM

7.5 cycles total from +120 deg f to +9 deg F. After stabilization, one hour minimum duration at each plateau. In-spec functional tests performed at each plateau.

5. MERMAL SIMULATION

Norst case hot and cold mission environments simulated in vacuum. During hot case, in-spec, operation is required for 6 of 14 consecutive hours. During cold case, in-spec operation is required for 14 consecutive hours.

6. HUHIDITY

120 hours exposure to 85% RH including four 24 haur temperature cycles of +60 deg F to +125 deg F, non-operating.